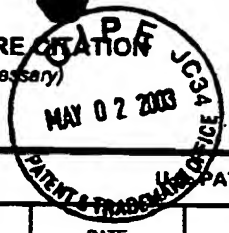


INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)



ATTY DOCKET NO. YOR920010368US		SERIAL NO. 10/059,422
Bojarczuk, Jr., et al.		
FILING January 31, 2002	GROUP 2814	

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>JD</i>	6,096,434	08/01/00	Yano, et al.			

FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)			

AMINER <i>JD</i>	DATE CONSIDERED <i>10/09/03</i>
---------------------	------------------------------------

AMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

BEST AVAILABLE COPY

(Use several sheets if necessary)

AUG 18 1964

YOR920010368US2

10/059422

Bojarczuk, Jr., et al.

January 31, 2002

2814

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

2 Brown

10/09/02

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPPE Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

(Use several sheets if necessary)

SERIAL NO. ~~Not Yet Assigned~~

APPLICANT(S)
Bojarczuk, Jr. et al.

FILING DATE
Concurrently Herewith

GROUP	2814
	Not Yet Assigned

U.S. PATENT DOCUMENTS

[illegible]

101017 U.S. PTO
10/059422
01/31/02

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

TD		"Crystalline Oxides on Silicon: The First Five Monolayers", Rodney A. McKee et al., Physical Review Letters, Volume 81, Number 14, October 5, 1998, pp. 3014-3017.
TD		"Epitaxial CeO ₂ on Silicon Substrates and the Potential of Si/CeO ₂ /Si for SOI Structures", A.H. Morshed et al., Mat. Res. Soc. Symp. V474, 339(1197).

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**This Page is Inserted by IFW Indexing and Scanning
Operations and is not part of the Official Record**

BEST AVAILABLE IMAGES

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images include but are not limited to the items checked:

- ☒ **BLACK BORDERS**
- ☐ **IMAGE CUT OFF AT TOP, BOTTOM OR SIDES**
- ☐ **FADED TEXT OR DRAWING**
- ☐ **BLURRED OR ILLEGIBLE TEXT OR DRAWING**
- ☐ **SKEWED/SLANTED IMAGES**
- ☐ **COLOR OR BLACK AND WHITE PHOTOGRAPHS**
- ☐ **GRAY SCALE DOCUMENTS**
- ☐ **LINES OR MARKS ON ORIGINAL DOCUMENT**
- ☐ **REFERENCE(S) OR EXHIBIT(S) SUBMITTED ARE POOR QUALITY**
- ☐ **OTHER:** _____

IMAGES ARE BEST AVAILABLE COPY.

As rescanning these documents will not correct the image problems checked, please do not report these problems to the IFW Image Problem Mailbox.